

2GHz BAND LOW NOISE AMPLIFIER

■ GENERAL DESCRIPTION

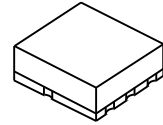
NJG1126HB6 is a low noise amplifier GaAs MMIC designed for 2GHz band application, and 1.7GHz to 3.8GHz operation with modified schematic.

This IC has the function which bypasses LNA, and high gain mode or low gain mode can be chosen high IIP3 and a low noise is achieved at the High gain mode.

And low current consumption can be achieved at the low gain mode because LNA enters the state of the standby.

An ultra-small and ultra-thin package of the USB8-B6 is adopted.

■ PACKAGE OUTLINE



NJG1126HB6

■ APPLICATIONS

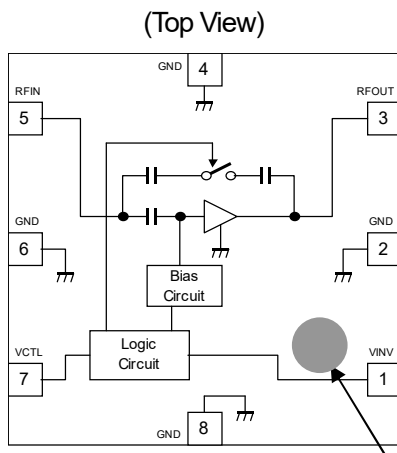
- W-CDMA and LTE application
- W-LAN and WiMAX application

Note: Please check the Application Note for LTE, WLAN and WiMAX

■ FEATURES

- Operating frequency range 1.7GHz to 3.8GHz
- Low voltage operation +2.7V typ.
- Low CTL voltage operation +1.85V typ.
- Low current consumption 2.2mA typ. @ $V_{CTL}=1.85V$
1 μ A typ. @ $V_{CTL}=0V$
- High gain 16.5dB typ. @ $V_{CTL}=1.85V, f_{RF}=2140MHz$
- Low noise figure 1.4dB typ. @ $V_{CTL}=1.85V, f_{RF}=2140MHz$
- Pin at 1dB Gain Compression point -12.0dBm typ. @ $V_{CTL}=1.85V, f_{RF}=2140MHz$
+11.0dBm typ. @ $V_{CTL}=0V, f_{RF}=2140MHz$
- High input IP3 0dBm typ. @ $V_{CTL}=1.85V, f_{RF}=2140MHz$
+16.0dBm typ. @ $V_{CTL}=0V, f_{RF}=2140MHz$
- Small package USB8-B6 (Package size: 1.5mmx1.5mmx0.55mm typ.)

■ PIN CONFIGURATION



1Pin INDEX

Pin Connection

1. VINV
2. GND
3. RF OUT
4. GND
5. RF IN
6. GND
7. VCTL
8. GND

Note: Specifications and description listed in this catalog are subject to change without prior notice.

■ ABSOLUTE MAXIMUM RATINGS

Ta=+25°C, Zs=Zl=50Ω

PARAMETERS	SYMBOL	CONDITIONS	RATINGS	UNITS
Supply voltage	V _{DD}		5.0	V
Inverter supply voltage	V _{INV}		5.0	V
Control voltage	V _{CTL}		5.0	V
Input power	P _{in}	V _{DD} =2.85V	+15	dBm
Power dissipation	P _D	on PCB board, T _{jmax} =150°C	135	mW
Operating temperature	T _{opr}		-40 to +85	°C
Storage temperature	T _{stg}		-55 to +150	°C

■ ELECTRICAL CHARACTERISTICS 1 (DC)

(General Conditions: V_{DD}=V_{INV}=2.85V, Ta=+25°C, Zs=Zl=50Ω)

PARAMETERS	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Operating voltage	V _{DD}		2.5	2.85	3.6	V
Inverter supply voltage	V _{INV}		2.5	2.85	3.6	V
Control voltage (High)	V _{CTL(H)}		1.5	1.85	V _{INV} +0.3	V
Control voltage (Low)	V _{CTL(L)}		0	0	0.3	V
Operating current1 (LNA High Gain Mode)	I _{DD1}	RF OFF, V _{CTL} =1.85V	-	2.2	3.2	mA
Operating current2 (LNA High Gain Mode)	I _{DD2}	RFOFF, V _{CTL} =0V	-	1	5	μA
Inverter current1 (LNA High Gain Mode)	I _{INV1}	RF OFF, V _{CTL} =1.85V	-	90	150	μA
Inverter current2 (LNA High Gain Mode)	I _{INV2}	RF OFF, V _{CTL} =0V	-	16	50	μA
Control current	I _{CTL}	RF OFF, V _{CTL} =1.85V	-	5	20	μA

■ **ELECTRICAL CHARACTERISTICS 2 (LNA High Gain Mode)**

(General Conditions: $V_{DD}=V_{INV}=2.7V$, $V_{CTL}=1.85V$, $f_{RF}=2140MHz$, $T_a=+25^{\circ}C$, $Z_s=Z_l=50\Omega$)

PARAMETERS	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Small signal gain1	Gain1	Exclude PCB & connector losses (IN: 0.09dB, OUT: 0.07dB)	15.0	16.5	19.0	dB
Noise figure1	NF1	Exclude PCB & connector losses (IN: 0.09dB)	-	1.4	1.7	dB
1dB gain compression output power1	$P_{-1dB(IN)1}$		-15.5	-12.0	-	dBm
3rd order Input Intercept Point1	IIP3_1	$f1=f_{RF}$, $f2=f_{RF}+100kHz$, $P_{in}=-32dBm$	-5.0	0	-	dBm
RF IN VSWR1	$VSWR_{I1}$		-	1.6	2.2	-
RF OUT VSWR1	$VSWR_{O1}$		-	1.5	2.2	-

■ **ELECTRICAL CHARACTERISTICS 2 (LNA Low Gain Mode)**

(General Conditions: $V_{DD}=V_{INV}=2.7V$, $V_{CTL}=0V$, $f_{RF}=2140MHz$, $T_a=+25^{\circ}C$, $Z_s=Z_l=50\Omega$)

PARAMETERS	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Small signal gain2	Gain2	Exclude PCB & connector losses (IN: 0.09dB, OUT: 0.07dB)	-10.0	-7.0	-5.5	dB
Noise figure2	NF2	Exclude PCB & connector losses (IN: 0.09dB)	-	7.0	10.0	dB
1dB gain compression output power2	$P_{-1dB(IN)2}$		+4.5	+11.0	-	dBm
3rd order Input Intercept Point2	IIP3_2	$F1=f_{RF}$, $f2=f_{RF}+100kHz$, $P_{in}=-16dBm$	0	+16.0	-	dBm
RF IN VSWR2	$VSWR_{I2}$		-	1.5	2.0	-
RF OUT VSWR2	$VSWR_{O2}$		-	1.5	2.2	-

■ TERMINAL INFORMATION

No.	SYMBOL	DESCRIPTION
1	VINV	Inverter supply voltage terminal. Please place a bypass capacitor between this and GND for avoiding RF noise from outside.
2	GND	Ground terminal. This terminal should be connected to the ground plane as close as possible for excellent RF performance.
3	RFOUT	RF output signal terminal. RF signal comes out from this terminal, and goes through an external matching circuit connected to this. This terminal doubles as the drain terminal of the LNA. Please connect this terminal to the power supply via inductor L3.
4	GND	Ground terminal. This terminal should be connected to the ground plane as close as possible for excellent RF performance.
5	RFIN	RF input signal terminal. RF signal is input through external matching circuit connected to this terminal. This terminal integrates an input DC blocking capacitor.
6	GND	Ground terminal. This terminal should be connected to the ground plane as close as possible for excellent RF performance.
7	VCTL	Control voltage terminal. Inputting a logic-high level, the LNA turn at high gain mode. Inputting a logic-low level, the LNA turn at Low gain mode.
8	GND	Ground terminal. This terminal should be connected to the ground plane as close as possible for excellent RF performance.

CAUTION

1) Ground terminal (No.2, 4, 6, 8) should be connected to the ground plane as close as possible for excellent RF performance, because distance to GND makes parasitic inductance.

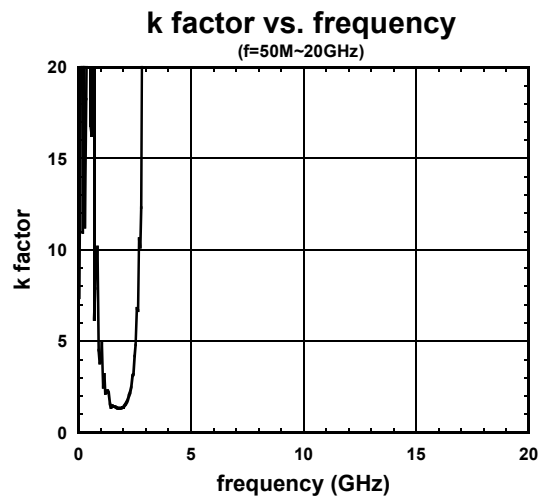
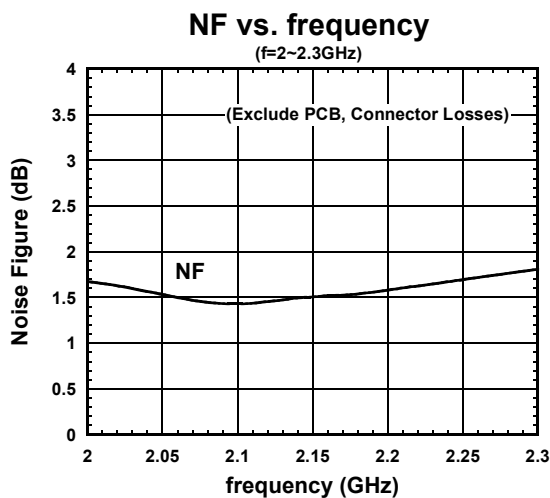
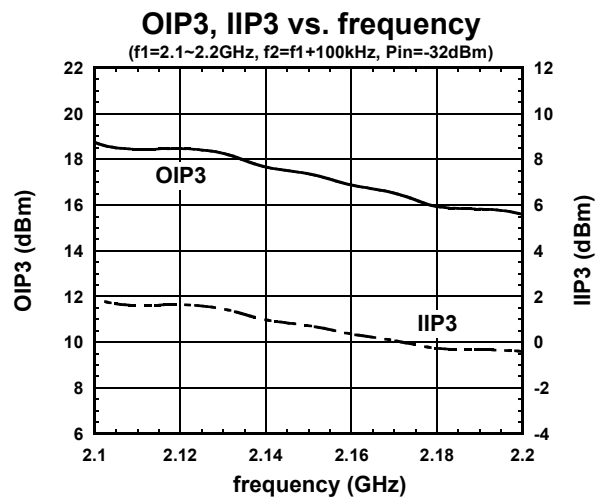
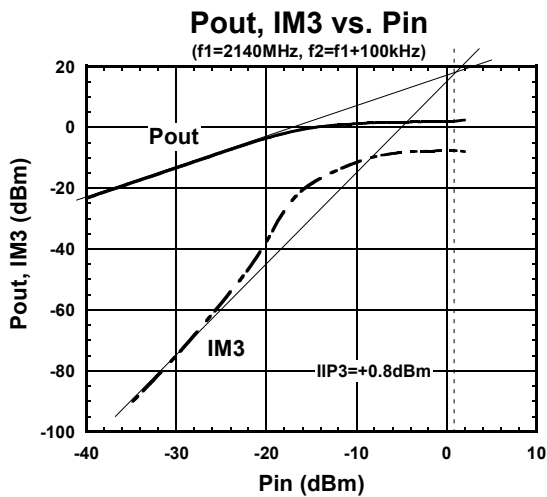
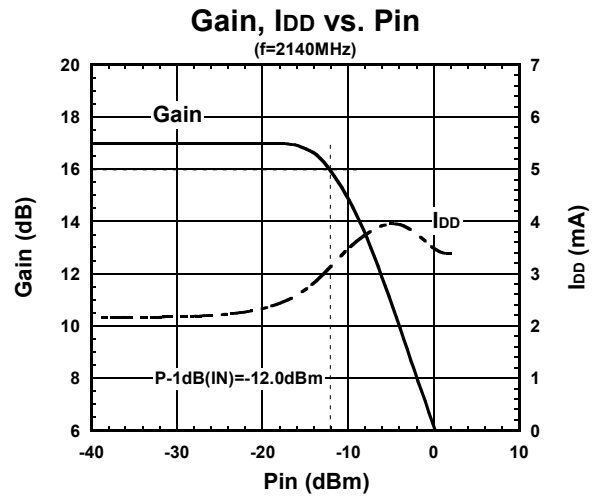
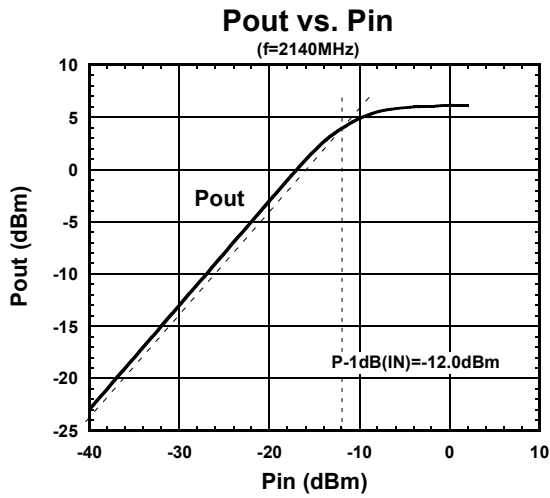
■ TRUTH TABLE

“H”=V_{CTL}(H), “L”=V_{CTL}(L)

V _{CTL}	LNA circuit	Bypass circuit	Mode select
L	OFF	ON	Low gain mode
H	ON	OFF	High gain mode

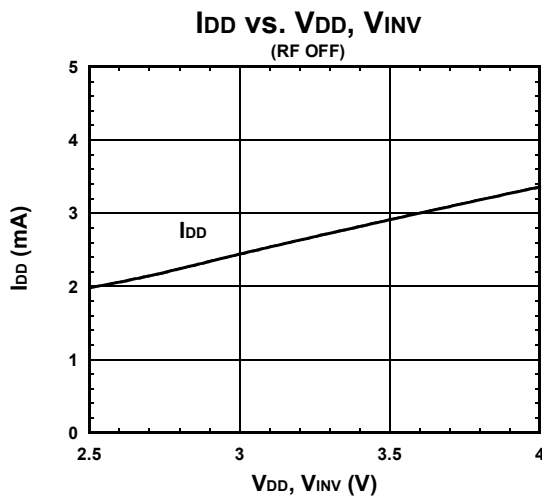
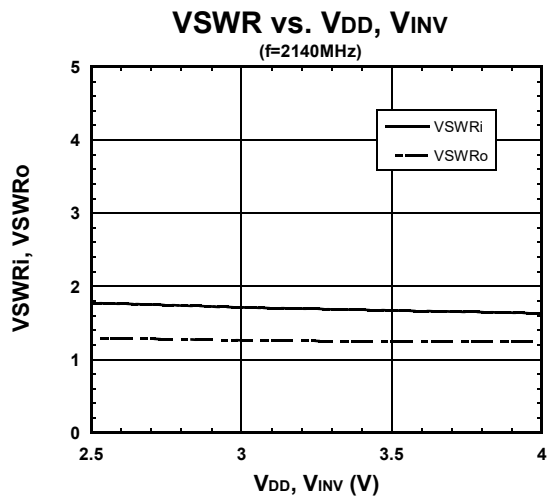
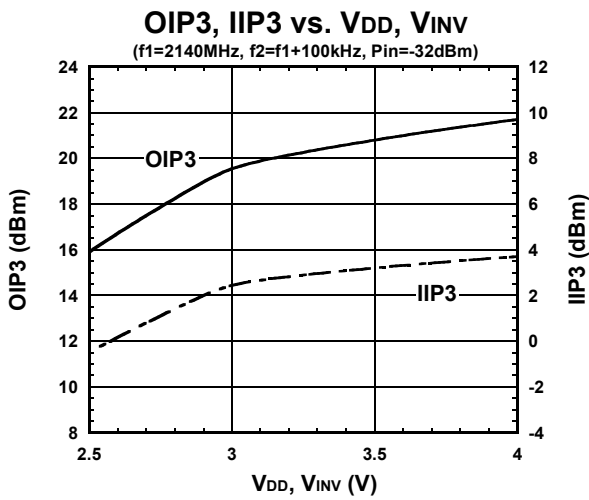
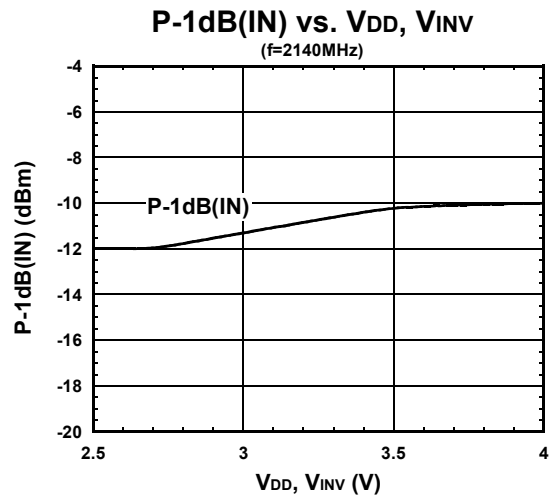
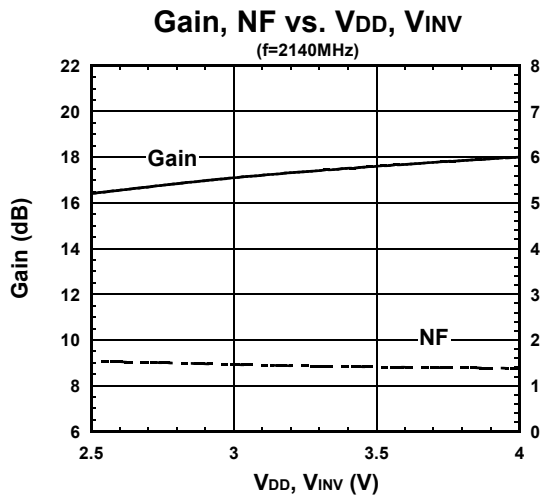
■ ELECTRICAL CHARACTERISTICS (LNA High Gain Mode)

General Conditions: $T_a=+25^\circ\text{C}$, $V_{DD}=V_{INV}=2.7\text{V}$, $V_{CTL}=1.85\text{V}$, $Z_s=Z_l=50\Omega$



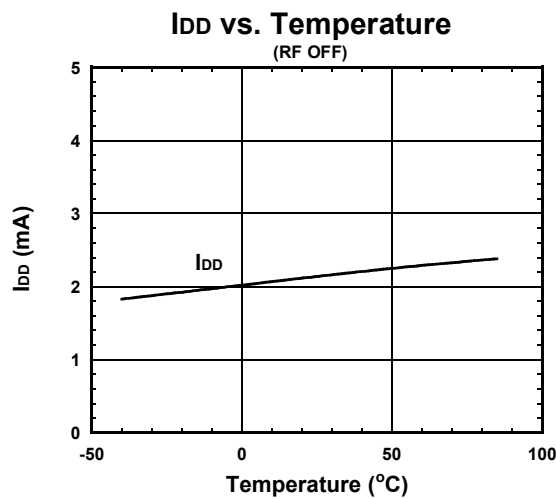
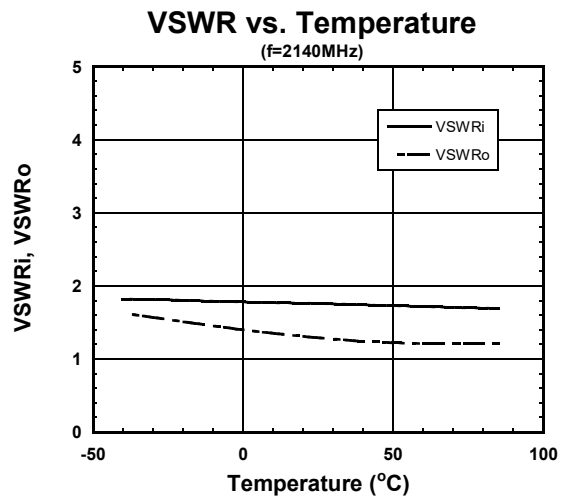
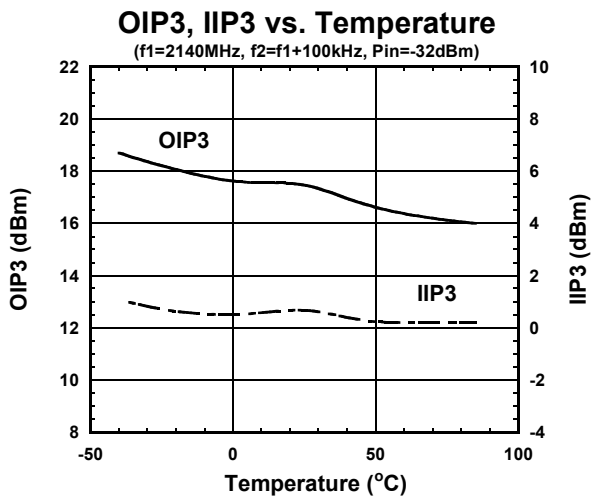
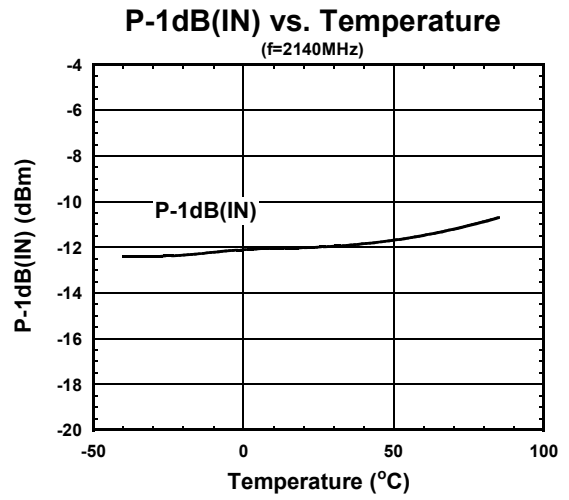
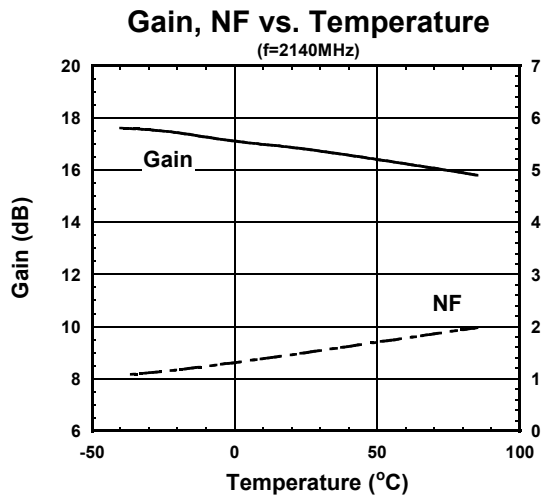
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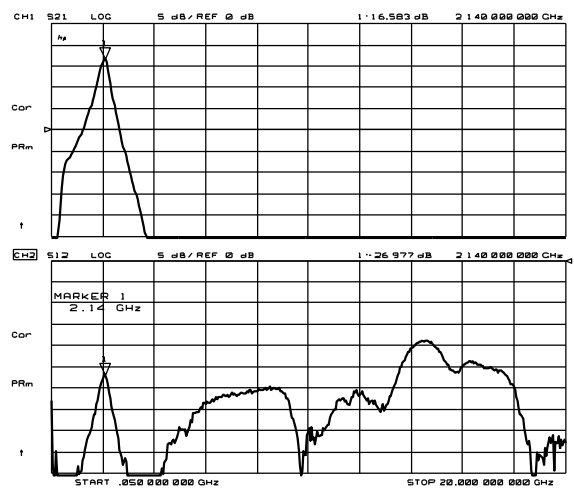
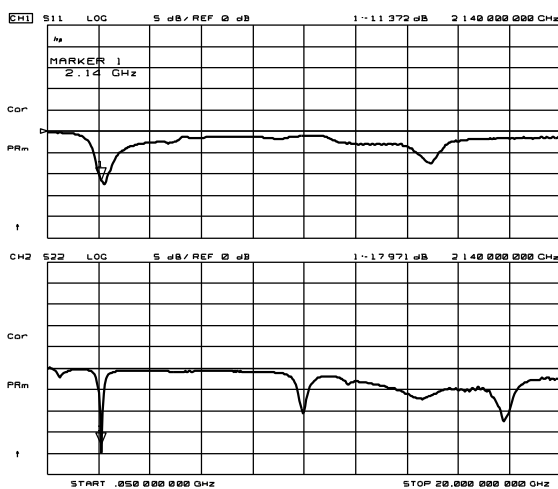
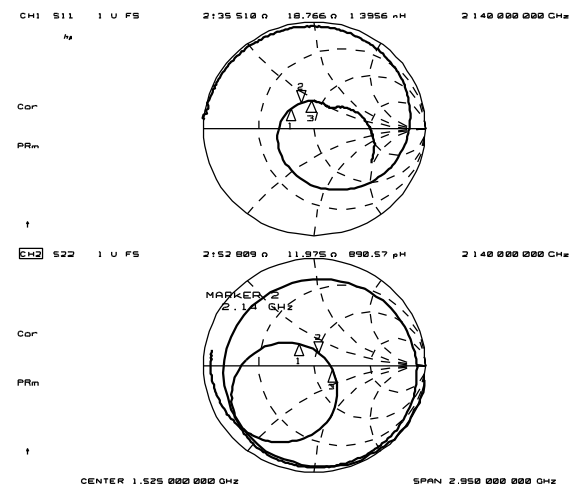
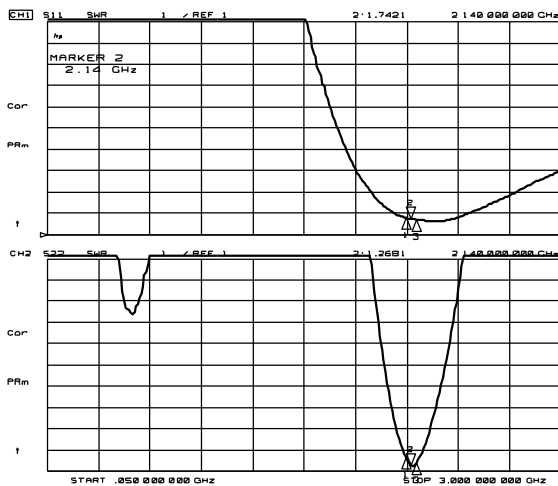
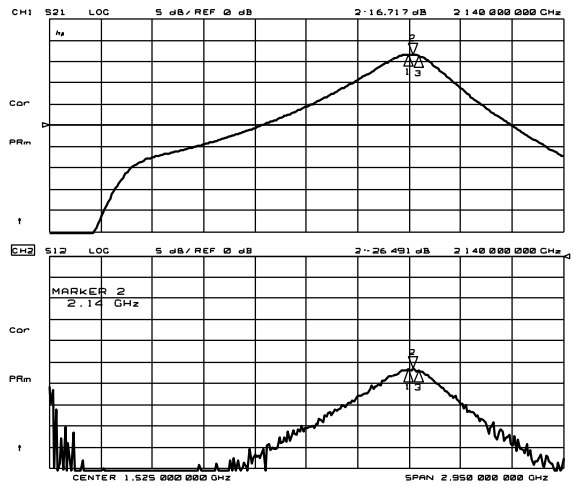
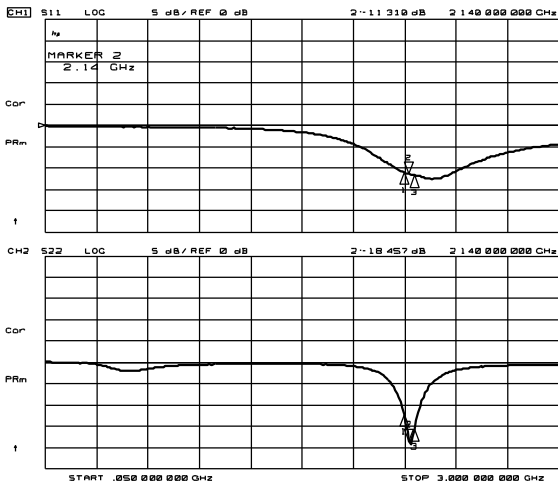
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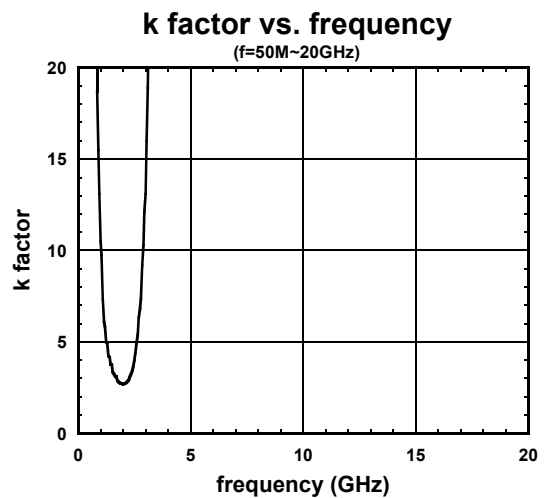
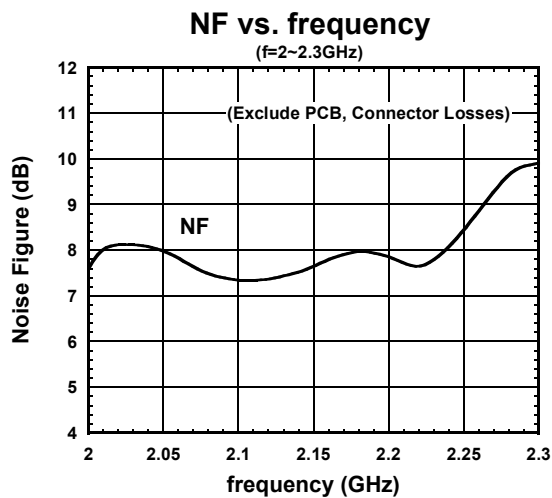
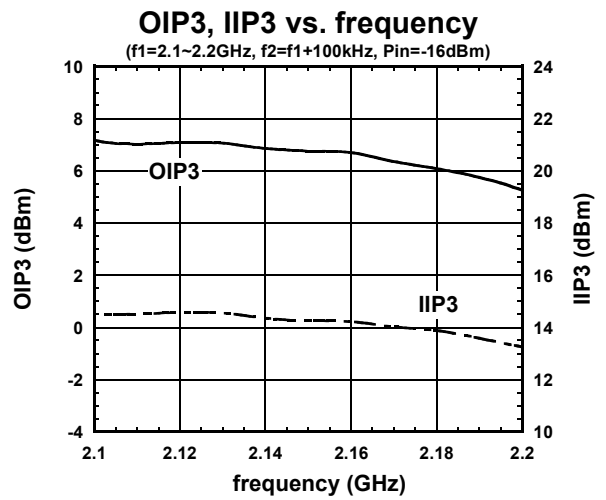
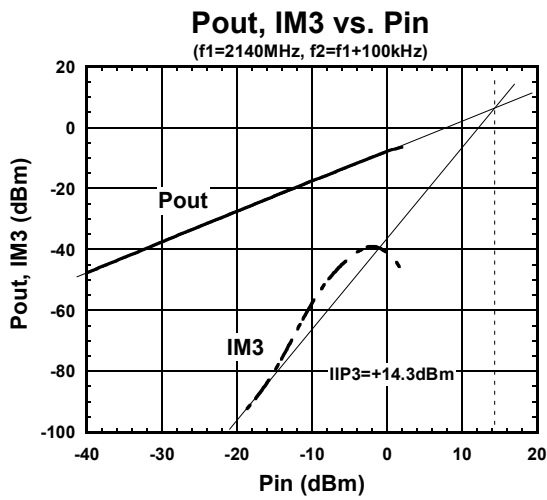
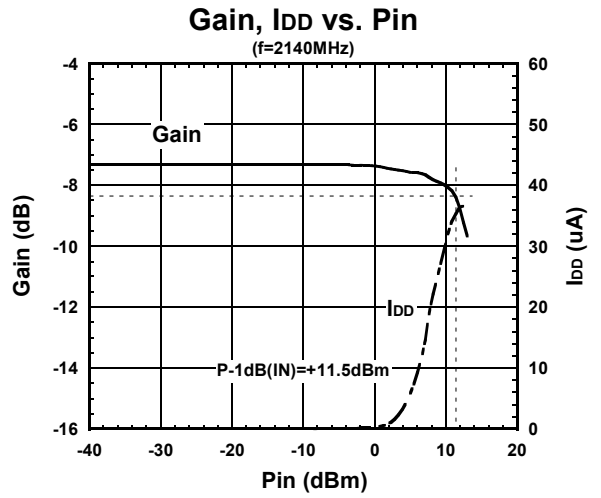
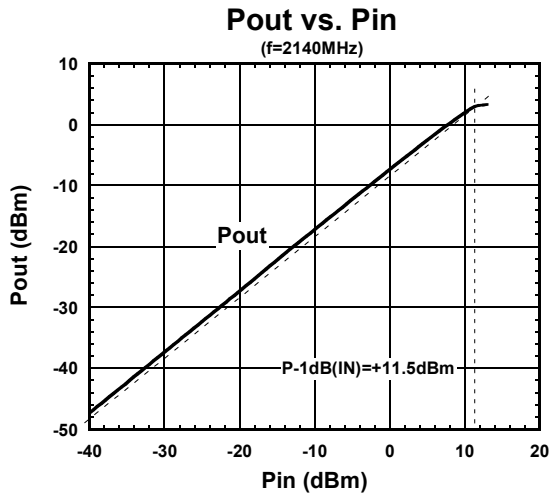
ELECTRICAL CHARACTERISTICS (LNA High Gain Mode)

General Conditions: $T_a = +25^\circ\text{C}$, $V_{DD} = V_{INV} = 2.7\text{V}$, $V_{CTL} = 1.85\text{V}$, $Z_s = Z_l = 50\Omega$



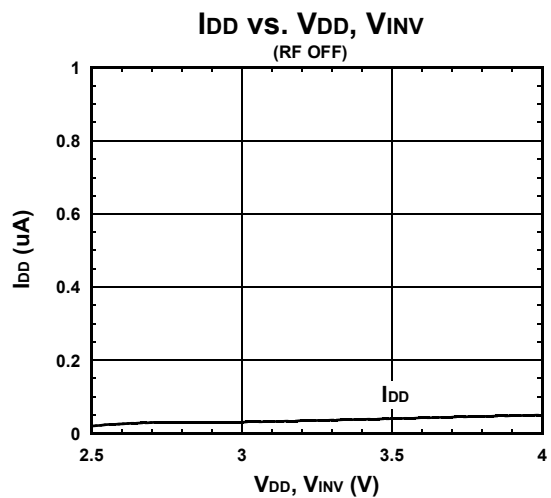
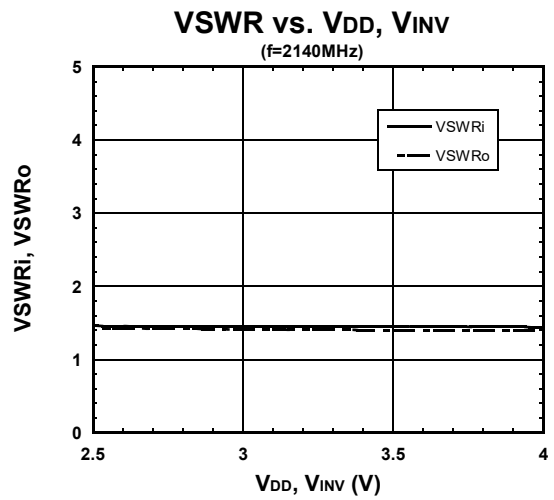
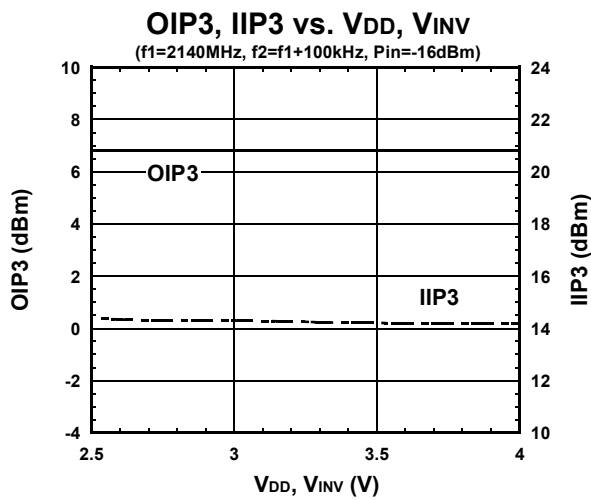
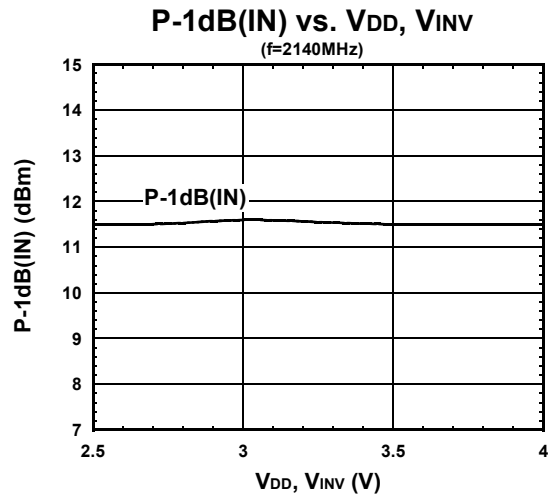
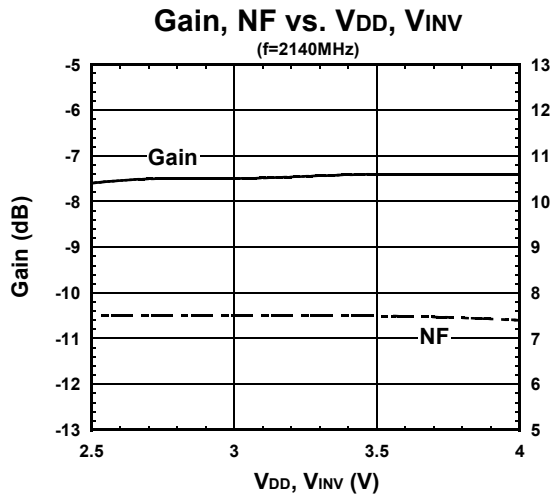
■ ELECTRICAL CHARACTERISTICS (LNA Low Gain Mode)

General Conditions: $T_a=+25^\circ\text{C}$, $V_{DD}=V_{INV}=2.7\text{V}$, $V_{CTL}=0\text{V}$, $Z_s=Z_l=50\Omega$



■ ELECTRICAL CHARACTERISTICS (LNA Low Gain Mode)

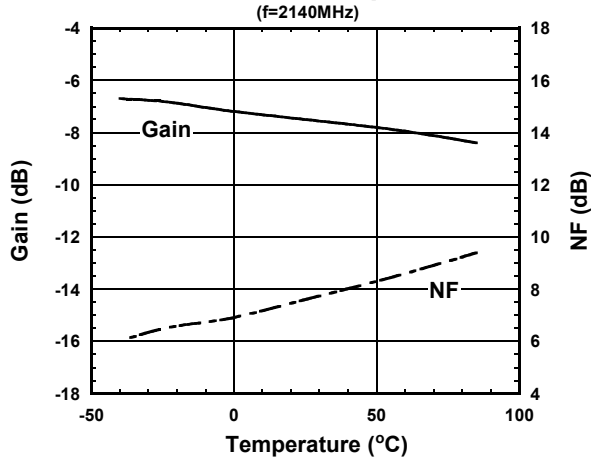
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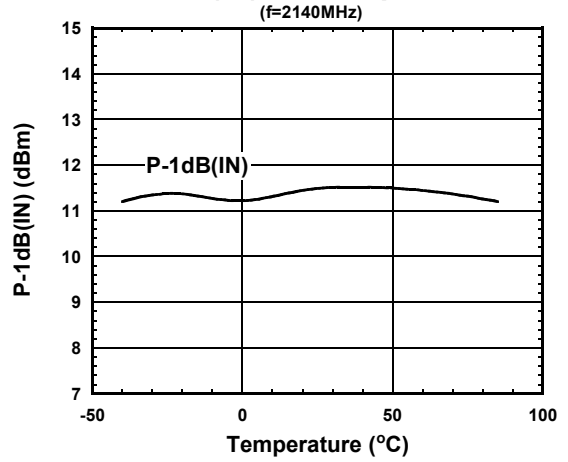
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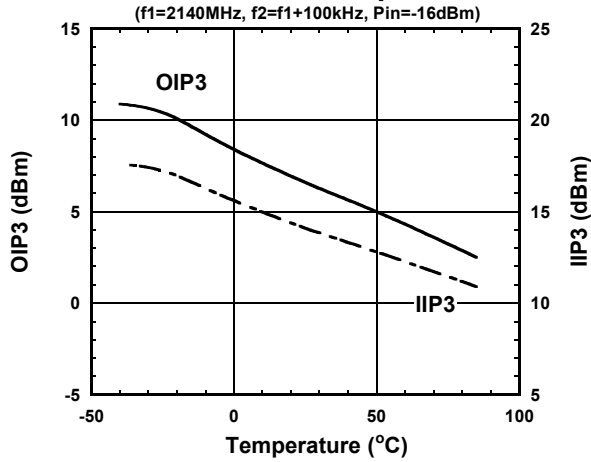
Gain, NF vs. Temperature



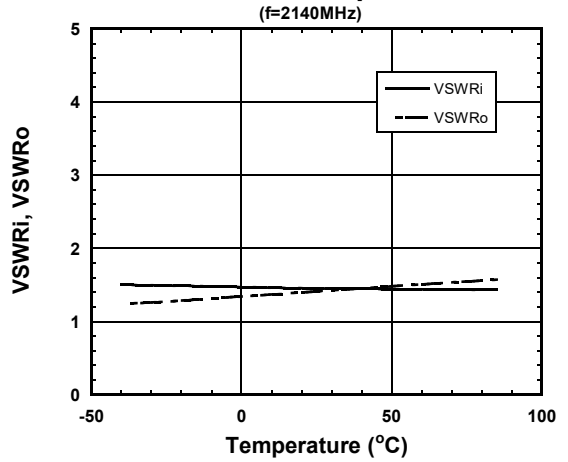
P-1dB(IN) vs. Temperature



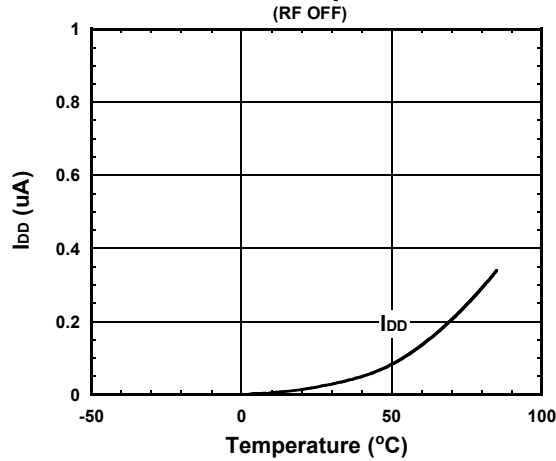
OIP3, IIP3 vs. Temperature



VSWR vs. Temperature

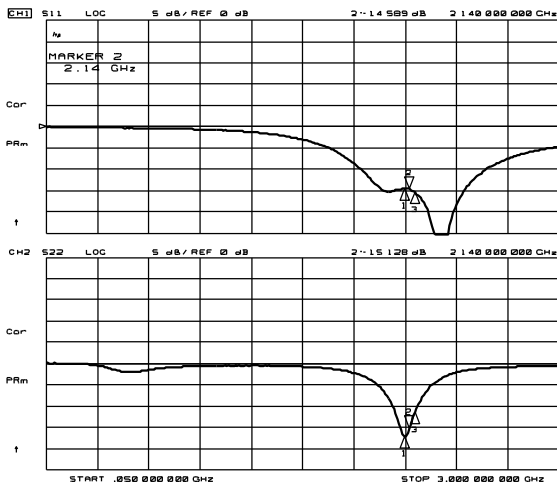


I_{DD} vs. Temperature



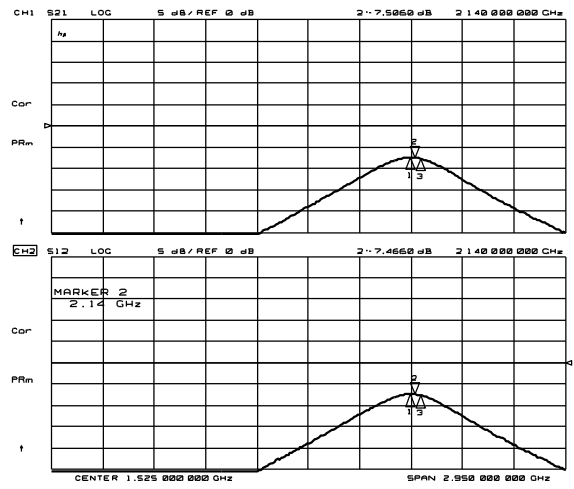
ELECTRICAL CHARACTERISTICS (LNA Low Gain Mode)

General Conditions: $T_a = +25^\circ\text{C}$, $V_{DD} = V_{INV} = 2.7\text{V}$, $V_{CTL} = 0\text{V}$, $Z_s = Z_l = 50\Omega$



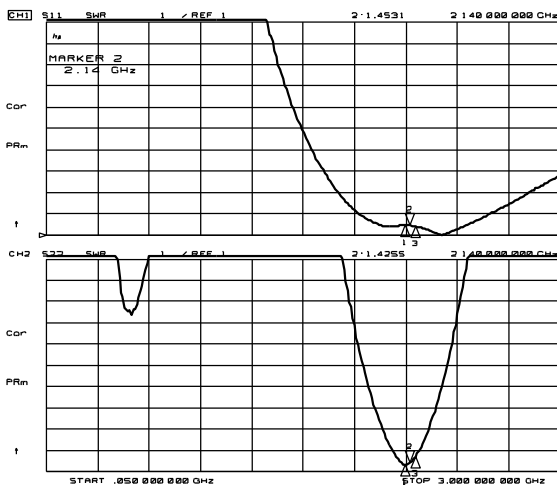
CH1 Markers
 1: -14.447 dB
 2: 11.000 GHz
 3: -15.361 dB
 2: 1.7000 GHz

CH2 Markers
 1: 17.023 dB
 2: 11.000 GHz
 3: 11.481 dB
 2: 1.7000 GHz



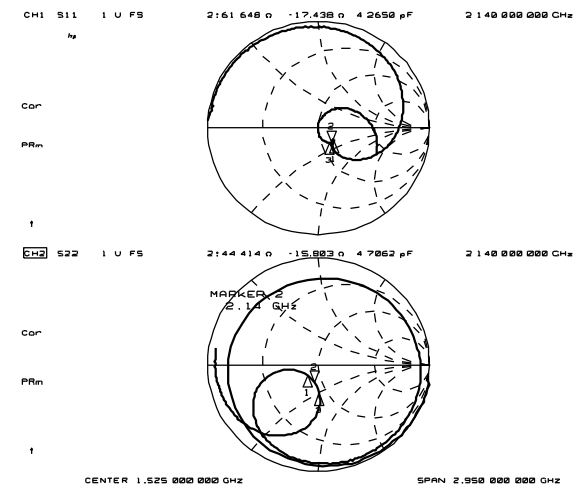
CH1 Markers
 1: -7.460 dB
 2: 11.000 GHz
 3: -7.714 dB
 2: 1.7000 GHz

CH2 Markers
 1: 7.440 dB
 2: 11.000 GHz
 3: 7.713 dB
 2: 1.7000 GHz



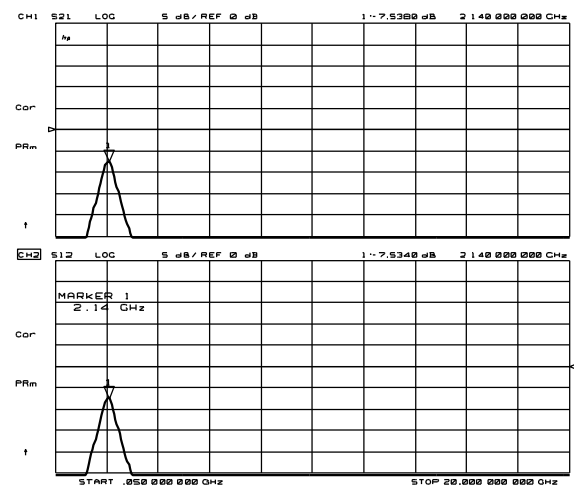
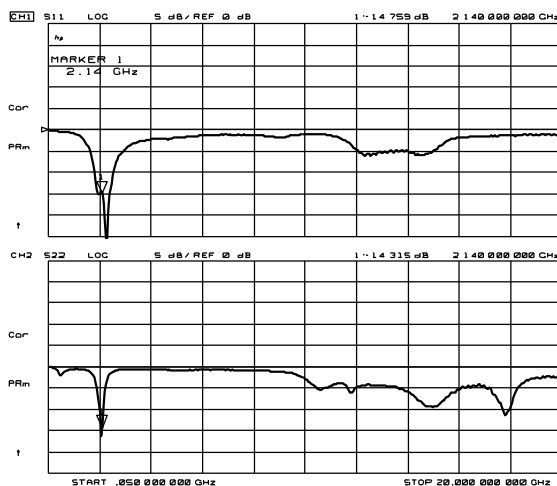
CH1 Markers
 1: 1.4668
 2: 11.000 GHz
 3: 1.4105
 2: 1.7000 GHz

CH2 Markers
 1: 1.3256
 2: 11.000 GHz
 3: 1.7266
 2: 1.7000 GHz

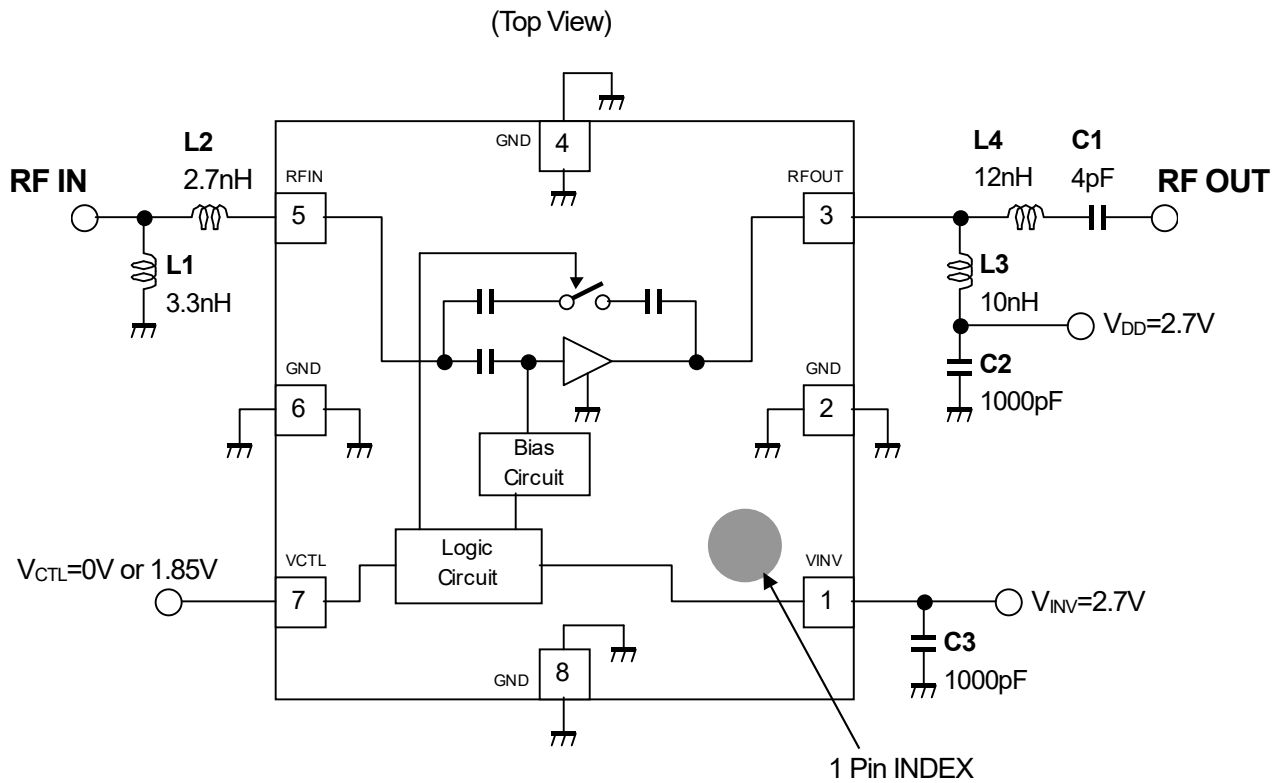


CH1 Markers
 1: 64.816 n
 2: 16.032 n
 3: 50.572 n
 4: 15.568 n
 2: 1.7000 GHz

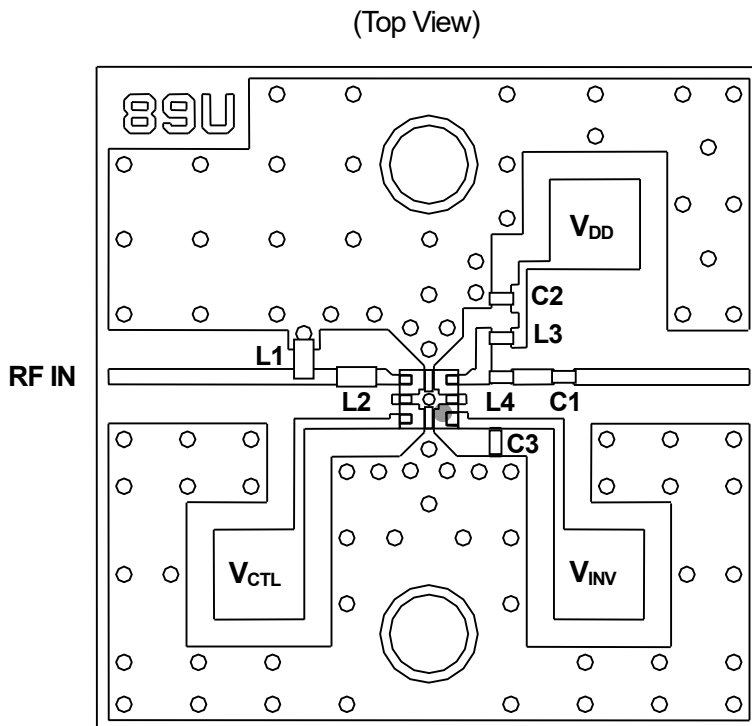
CH2 Markers
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 2: 6.0020 n
 3: 44.195 n
 4: 25.348 n
 2: 1.7000 GHz



APPLICATION CIRCUIT



TEST PCB LAYOUT

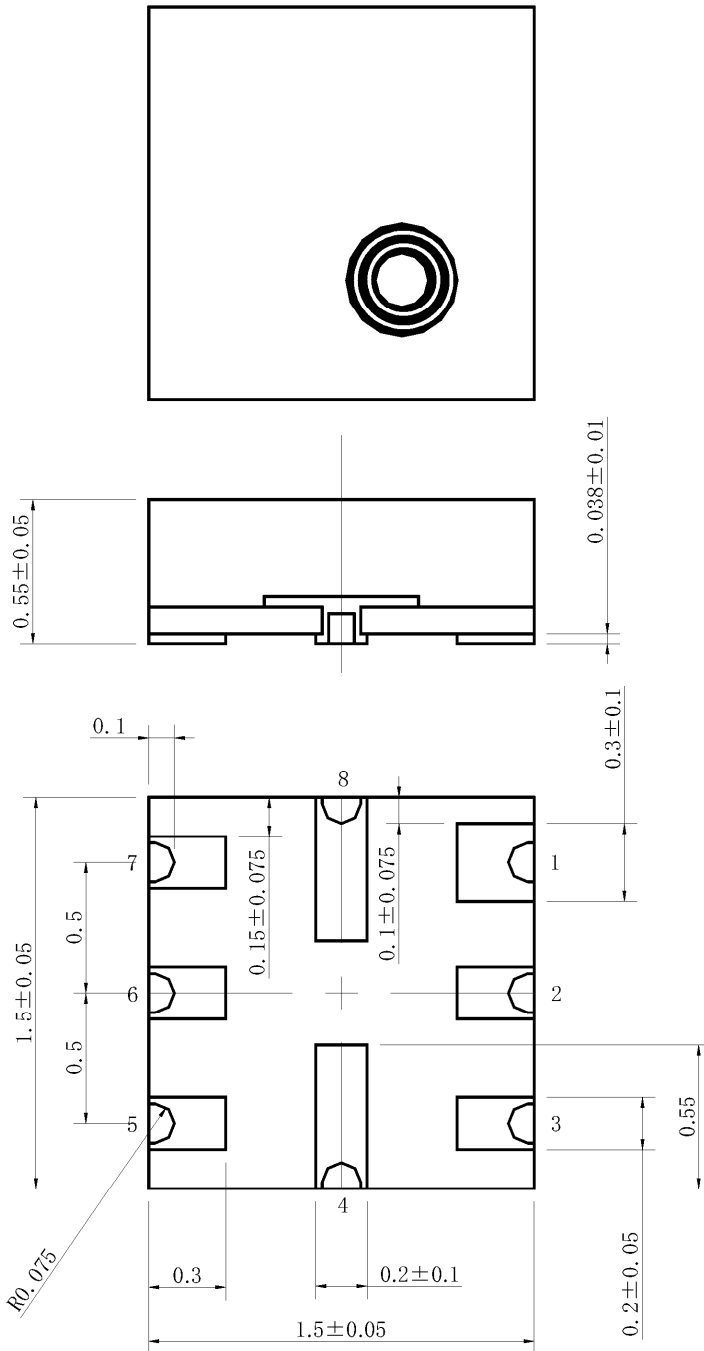


PARTS LIST

Parts ID	Comment
L1, L2	TAIYO-YUDEN (HK1005)
L3, L4	TDK (MLG0603Q)
C1 to C3	MURATA (GRM03)

PCB (FR-4)
 t=0.2mm
 MICROSTRIP LINE WIDTH
 =0.4mm ($Z_0=50\Omega$)
 PCB SIZE=17.0mmx17.0mm

■ PACKAGE OUTLINE (USB8-B6)



UNIT : mm

SUBSTRATE MATERIAL: Glass epoxy board
 TERMINAL FINISH: Au Plating (Cu/Ni/Au)
 MOLD MATERIAL: Epoxy resin
 MASS(TYP.): 2.4mg

Cautions on using this product

This product contains Gallium-Arsenide (GaAs) which is a harmful material.

- Do NOT eat or put into mouth.
- Do NOT dispose in fire or break up this product.
- Do NOT chemically make gas or powder with this product.
- To waste this product, please obey the relating law of your country.

[CAUTION]

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This product may be damaged with electric static discharge (ESD) or spike voltage. Please handle with care to avoid these damages.

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3. This product and any technical information relating thereto are subject to complementary export controls (so-called KNOW controls) under the Foreign Exchange and Foreign Trade Law, and related politics ministerial ordinance of the law. (Note that the complementary export controls are inapplicable to any application-specific products, except rockets and pilotless aircraft, that are insusceptible to design or program changes.) Accordingly, when exporting or carrying abroad this product, follow the Foreign Exchange and Foreign Trade Control Law and its related regulations with respect to the complementary export controls.
4. The technical information described in this document shows typical characteristics and example application circuits for the products. The release of such information is not to be construed as a warranty of or a grant of license under our or any third party's intellectual property rights or any other rights.
5. The products listed in this document are intended and designed for use as general electronic components in standard applications (office equipment, telecommunication equipment, measuring instruments, consumer electronic products, amusement equipment etc.). Those customers intending to use a product in an application requiring extreme quality and reliability, for example, in a highly specific application where the failure or misoperation of the product could result in human injury or death should first contact us.
 - Aerospace Equipment
 - Equipment Used in the Deep Sea
 - Power Generator Control Equipment (nuclear, steam, hydraulic, etc.)
 - Life Maintenance Medical Equipment
 - Fire Alarms / Intruder Detectors
 - Vehicle Control Equipment (automotive, airplane, railroad, ship, etc.)
 - Various Safety Devices
 - Traffic control system
 - Combustion equipment

In case your company desires to use this product for any applications other than general electronic equipment mentioned above, make sure to contact our company in advance. Note that the important requirements mentioned in this section are not applicable to cases where operation requirements such as application conditions are confirmed by our company in writing after consultation with your company.

6. We are making our continuous effort to improve the quality and reliability of our products, but semiconductor products are likely to fail with certain probability. In order to prevent any injury to persons or damages to property resulting from such failure, customers should be careful enough to incorporate safety measures in their design, such as redundancy feature, fire containment feature and fail-safe feature. We do not assume any liability or responsibility for any loss or damage arising from misuse or inappropriate use of the products.
7. The products have been designed and tested to function within controlled environmental conditions. Do not use products under conditions that deviate from methods or applications specified in this datasheet. Failure to employ the products in the proper applications can lead to deterioration, destruction or failure of the products. We shall not be responsible for any bodily injury, fires or accident, property damage or any consequential damages resulting from misuse or misapplication of the products.
8. **Quality Warranty**
 - 8-1. **Quality Warranty Period**

In the case of a product purchased through an authorized distributor or directly from us, the warranty period for this product shall be one (1) year after delivery to your company. For defective products that occurred during this period, we will take the quality warranty measures described in section 8-2. However, if there is an agreement on the warranty period in the basic transaction agreement, quality assurance agreement, delivery specifications, etc., it shall be followed.
 - 8-2. **Quality Warranty Remedies**

When it has been proved defective due to manufacturing factors as a result of defect analysis by us, we will either deliver a substitute for the defective product or refund the purchase price of the defective product.

Note that such delivery or refund is sole and exclusive remedies to your company for the defective product.
 - 8-3. **Remedies after Quality Warranty Period**

With respect to any defect of this product found after the quality warranty period, the defect will be analyzed by us. On the basis of the defect analysis results, the scope and amounts of damage shall be determined by mutual agreement of both parties. Then we will deal with upper limit in Section 8-2. This provision is not intended to limit any legal rights of your company.
9. Anti-radiation design is not implemented in the products described in this document.
10. The X-ray exposure can influence functions and characteristics of the products. Confirm the product functions and characteristics in the evaluation stage.
11. WLCSP products should be used in light shielded environments. The light exposure can influence functions and characteristics of the products under operation or storage.
12. Warning for handling Gallium and Arsenic (GaAs) products (Applying to GaAs MMIC, Photo Reflector). These products use Gallium (Ga) and Arsenic (As) which are specified as poisonous chemicals by law. For the prevention of a hazard, do not burn, destroy, or process chemically to make them as gas or power. When the product is disposed of, please follow the related regulation and do not mix this with general industrial waste or household waste.
13. Please contact our sales representatives should you have any questions or comments concerning the products or the technical information.



Nisshinbo Micro Devices Inc.

Official website

<https://www.nisshinbo-microdevices.co.jp/en/>

Purchase information

<https://www.nisshinbo-microdevices.co.jp/en/buy/>